

Notice of References Cited

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Application/Control No.	Applicant(s)/Pate	nt Under
10/014,310	Reexamination SHAH ET AL.	
Examiner	Art Unit	
Andrew L Oltmans	1742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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